L1 L2 GEN

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192227 S SEMICONDUCT? OR SILICON OR SI

13302 S (IMPURITIES OR IMPURITY) AND CARBON AND NITROGEN AND OXY

5268 S L1 AND L2

1467 S L3 AND AMORPHOUS

125 S L4 AND RECRYSTAL?

0 S L5 AND CCLS/257

0 S 257/CCLR

9 S L5 AND (THIN FILM)

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- 3. 5,117,057, May 26, 1992, Insecticidal N' substituted-N-N'-disubstituted-hydrazines; Adam C. Hsu, et al., 564/149; 544/224, 335, 406; 546/316, 324, 325, 332; 548/213, 214, 238, 248, 255, 537, 563; 549/65, 72, 436, 484, 487, 494, 496, 553; 556/419; 558/6, 10, 17, 58, 273, 275, 404, 415; 560/27, 29, 30, 34, 138, 163, 221, 251; 564/12, 35, 36, 74, 81, 148, 150, 151 [IMAGE AVAILABLE]
- 4. 5,108,843, Apr. 28, 1992, <u>Thin film semiconductor</u> and process for producing the same; Kouichi Ohtaka, et al., 428/446, 212, 428, 698, 699, 701, 704 [IMAGE AVAILABLE]
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- 8. 4,727,044, Feb. 23, 1988, Method of making a <u>thin</u> <u>film</u> transistor with laser <u>recrystallized</u> source and drain; Shunpei Yamazaki, 437/45; 257/52, 347; 437/46, 82, 83, 100, 101, 907
 - 9. 4,668,331, May 26, 1987, Method for forming single crystals of silicon by use of a standing hypersonic wave; Jeremiah P. Ostriker, 156/603; 148/DIG.98; 156/620.71, DIG.91

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